

SECTION H — ELECTRICITY

H10 SEMICONDUCTOR DEVICES; ELECTRIC SOLID-STATE DEVICES NOT OTHERWISE PROVIDED FOR**H10N ELECTRIC SOLID-STATE DEVICES NOT OTHERWISE PROVIDED FOR [2023.01]****Note(s) [2024.01]**

In this subclass, the periodic system used is the I to VIII group system indicated in the Periodic Table under Note (3) of section C.

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99/00	

Thermoelectric or thermomagnetic devices [2023.01]

10/00	Thermoelectric devices comprising a junction of dissimilar materials, i.e. devices exhibiting Seebeck or Peltier effects (integrated devices or assemblies of multiple devices H10N 19/00) [2023.01]	10/81	• •	Structural details of the junction [2023.01]
		10/813	• • •	the junction being separable, e.g. using a spring [2023.01]
		10/817	• • •	the junction being non-separable, e.g. being cemented, sintered or soldered [2023.01]
		10/82	• •	Interconnections [2023.01]
		10/85	• •	Thermoelectric active materials [2023.01]
		10/851	• • •	comprising inorganic compositions [2023.01]
		10/852	• • • •	comprising tellurium, selenium or sulfur [2023.01]
10/01	• Manufacture or treatment [2023.01]	10/853	• • • •	comprising arsenic, antimony or bismuth (H10N 10/852 takes precedence) [2023.01]
10/10	• operating with only the Peltier or Seebeck effects [2023.01]	10/854	• • • •	comprising only metals (H10N 10/852, H10N 10/853 take precedence) [2023.01]
10/13	• • characterised by the heat-exchanging means at the junction [2023.01]	10/855	• • • •	comprising compounds containing boron, carbon, oxygen or nitrogen [2023.01]
10/17	• • characterised by the structure or configuration of the cell or thermocouple forming the device [2023.01]	10/856	• • •	comprising organic compositions [2023.01]
10/80	• Constructional details [2023.01]			

H10N

- 10/857 • • • comprising compositions changing continuously or discontinuously inside the material [2023.01]
 - 15/00 Thermoelectric devices without a junction of dissimilar materials; Thermomagnetic devices, e.g. using the Nernst-Ettingshausen effect** (integrated devices or assemblies of multiple devices H10N 19/00) [2023.01]
 - 15/10 • Thermoelectric devices using thermal change of the dielectric constant, e.g. working above and below the Curie point [2023.01]
 - 15/20 • Thermomagnetic devices using thermal change of the magnetic permeability, e.g. working above and below the Curie point [2023.01]
 - 19/00 Integrated devices, or assemblies of multiple devices, comprising at least one thermoelectric or thermomagnetic element covered by groups H10N 10/00-H10N 15/00** [2023.01]
- Piezoelectric, electrostrictive or magnetostrictive devices** [2023.01]
- 30/00 Piezoelectric or electrostrictive devices** (integrated devices or assemblies of multiple devices H10N 39/00) [2023.01]
 - 30/01 • Manufacture or treatment [2023.01]
 - 30/02 • • Forming enclosures or casings [2023.01]
 - 30/03 • • Assembling devices that include piezoelectric or electrostrictive parts [2023.01]
 - 30/04 • • Treatments to modify a piezoelectric or electrostrictive property, e.g. polarisation characteristics, vibration characteristics or mode tuning [2023.01]
 - 30/045 • • • by polarising [2023.01]
 - 30/05 • • Manufacture of multilayered piezoelectric or electrostrictive devices, or parts thereof, e.g. by stacking piezoelectric bodies and electrodes [2023.01]
 - 30/053 • • • by integrally sintering piezoelectric or electrostrictive bodies and electrodes [2023.01]
 - 30/057 • • • by stacking bulk piezoelectric or electrostrictive bodies and electrodes [2023.01]
 - 30/06 • • Forming electrodes or interconnections, e.g. leads or terminals [2023.01]
 - 30/063 • • • Forming interconnections, e.g. connection electrodes of multilayered piezoelectric or electrostrictive parts [2023.01]
 - 30/067 • • • Forming single-layered electrodes of multilayered piezoelectric or electrostrictive parts [2023.01]
 - 30/07 • • Forming of piezoelectric or electrostrictive parts or bodies on an electrical element or another base [2023.01]
 - 30/071 • • • Mounting of piezoelectric or electrostrictive parts together with semiconductor elements, or other circuit elements, on a common substrate [2023.01]
 - 30/072 • • • by laminating or bonding of piezoelectric or electrostrictive bodies [2023.01]
 - 30/073 • • • • by fusion of metals or by adhesives [2023.01]
 - 30/074 • • • by depositing piezoelectric or electrostrictive layers, e.g. aerosol or screen printing [2023.01]
 - 30/076 • • • • by vapour phase deposition [2023.01]
 - 30/077 • • • • by liquid phase deposition [2023.01]
 - 30/078 • • • • • by sol-gel deposition [2023.01]
 - 30/079 • • • • using intermediate layers, e.g. for growth control [2023.01]
 - 30/08 • • Shaping or machining of piezoelectric or electrostrictive bodies [2023.01]
 - 30/081 • • • by coating or depositing using masks, e.g. lift-off [2023.01]
 - 30/082 • • • by etching, e.g. lithography [2023.01]
 - 30/084 • • • by moulding or extrusion [2023.01]
 - 30/085 • • • by machining [2023.01]
 - 30/086 • • • • by polishing or grinding [2023.01]
 - 30/088 • • • • by cutting or dicing [2023.01]
 - 30/089 • • • • by punching [2023.01]
 - 30/09 • • Forming piezoelectric or electrostrictive materials [2023.01]
 - 30/092 • • • Forming composite materials [2023.01]
 - 30/093 • • • Forming inorganic materials [2023.01]
 - 30/095 • • • • by melting [2023.01]
 - 30/097 • • • • by sintering [2023.01]
 - 30/098 • • • Forming organic materials [2023.01]
 - 30/20 • with electrical input and mechanical output, e.g. functioning as actuators or vibrators [2023.01]
 - 30/30 • with mechanical input and electrical output, e.g. functioning as generators or sensors [2023.01]
 - 30/40 • with electrical input and electrical output, e.g. functioning as transformers [2023.01]
 - 30/50 • having a stacked or multilayer structure [2023.01]
 - 30/60 • having a coaxial cable structure [2023.01]
 - 30/80 • Constructional details [2023.01]
 - 30/85 • • Piezoelectric or electrostrictive active materials [2023.01]
 - 30/853 • • • Ceramic compositions [2023.01]
 - 30/857 • • • Macromolecular compositions [2023.01]
 - 30/87 • • Electrodes or interconnections, e.g. leads or terminals [2023.01]
 - 30/88 • • Mounts; Supports; Enclosures; Casings [2023.01]
 - 35/00 Magnetostrictive devices** (integrated devices or assemblies of multiple devices H10N 39/00) [2023.01]
 - 35/01 • Manufacture or treatment [2023.01]
 - 35/80 • Constructional details [2023.01]
 - 35/85 • • Magnetostrictive active materials [2023.01]
 - 39/00 Integrated devices, or assemblies of multiple devices, comprising at least one piezoelectric, electrostrictive or magnetostrictive element covered by groups H10N 30/00-H10N 35/00** [2023.01]
- Galvanomagnetic or similar magnetic-effect devices** [2023.01]
- 50/00 Galvanomagnetic devices** (Hall-effect devices H10N 52/00; integrated devices or assemblies of multiple devices H10N 59/00) [2023.01]
 - 50/01 • Manufacture or treatment [2023.01]
 - 50/10 • Magnetoresistive devices [2023.01]
 - 50/20 • Spin-polarised current-controlled devices (magnetoresistive devices H10N 50/10) [2023.01]
 - 50/80 • Constructional details [2023.01]
 - 50/85 • • Materials of the active region [2023.01]
 - 52/00 Hall-effect devices** (integrated devices or assemblies of multiple devices H10N 59/00) [2023.01]
 - 52/01 • Manufacture or treatment [2023.01]
 - 52/80 • Constructional details [2023.01]
 - 52/85 • • Materials of the active region [2023.01]

59/00 **Integrated devices, or assemblies of multiple devices, comprising at least one galvanomagnetic or Hall-effect element covered by groups H10N 50/00-H10N 52/00 (MRAM devices H10B 61/00) [2023.01]**

Superconducting devices [2023.01]

60/00 **Superconducting devices** (integrated devices or assemblies of multiple devices H10N 69/00) [2023.01]

- 60/01 • Manufacture or treatment [2023.01]
- 60/10 • Junction-based devices [2023.01]
- 60/12 • • Josephson-effect devices [2023.01]
- 60/20 • Permanent superconducting devices [2023.01]
- 60/30 • Devices switchable between superconducting and normal states [2023.01]
- 60/35 • • Cryotrons [2023.01]
- 60/355 • • • Power cryotrons [2023.01]
- 60/80 • Constructional details [2023.01]
- 60/81 • • Containers; Mountings [2023.01]
- 60/82 • • Current path [2023.01]
- 60/83 • • Element shape [2023.01]
- 60/84 • • Switching means for devices switchable between superconducting and normal states [2023.01]
- 60/85 • • Superconducting active materials [2023.01]

69/00 **Integrated devices, or assemblies of multiple devices, comprising at least one superconducting element covered by group H10N 60/00 [2023.01]**

Other electric solid-state devices [2023.01]

70/00 **Solid-state devices having no potential barriers, and specially adapted for rectifying, amplifying, oscillating or switching** (integrated devices or assemblies of multiple devices H10N 79/00) [2023.01]

70/10 • Solid-state travelling-wave devices [2023.01]

70/20 • Multistable switching devices, e.g. memristors [2023.01]

79/00 **Integrated devices, or assemblies of multiple devices, comprising at least one solid-state element covered by group H10N 70/00** (ReRAM devices H10B 63/00; PCRAM devices H10B 63/10) [2023.01]

80/00 **Bulk negative-resistance effect devices** (integrated devices or assemblies of multiple devices H10N 89/00) [2023.01]

80/10 • Gunn-effect devices [2023.01]

89/00 **Integrated devices, or assemblies of multiple devices, comprising at least one bulk negative resistance effect element covered by group H10N 80/00 [2023.01]**

97/00 **Electric solid-state thin-film or thick-film devices, not otherwise provided for [2023.01]**

99/00 **Subject matter not provided for in other groups of this subclass [2023.01]**